Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/796,092	TAKE, KEIJIRO
Examiner	Art Unit
Tri H. Phan	2661

SEARCHED					
Class	Subclass	Date	Examiner		
370	320,335, 342,441, 479,203	11/30/2004	TP		
370	350,332	11/30/2004	TP		
370	508-510	11/30/2004	TP		
375	200	11/30/2004	TP		
Updated	search	6/17/2005	TP		
Updated	search	1/19/2006	TP		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
,					

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
EAST, IEEE, Internet search	11/30/2004	TP
Consulted with Sam Phirin (Pri)	4/7/2005	ТР
Consulted with Brian Nguyen	6/15/2005	TP
Inventorship search	1/19/2006	ТР